# 5V ECL 3-Bit 4:1 Mux-Latch

### Description

The MC10E/100E156 contains three 4:1 multiplexers followed by transparent latches with differential outputs. When both Latch Enables (LEN1, LEN2) are LOW, the latch is transparent, and output date is controlled by the multiplexer select controls (SEL0, SEL1). A logic HIGH on either LEN1 or LEN2 (or both) latches the outputs. The Master Reset (MR) overrides all other controls to set the Q outputs LOW.

The 100 Series contains temperature compensation.

### Features

- 950 ps Max. D to Output
- 850 ps Max. LEN to Output
- Differential Outputs
- Asynchronous Master Reset
- Dual Latch-Enables
- PECL Mode Operating Range:  $V_{CC}$  = 4.2 V to 5.7 V with  $V_{EE}$  = 0 V
- NECL Mode Operating Range:  $V_{CC}= 0 V$ with  $V_{EE} = -4.2 V$  to -5.7 V
- Internal Input 50 k $\Omega$  Pulldown Resistors
- ESD Protection: Human Body Model; > 2 kV, Machine Model; > 200 V
- Meets or Exceeds JEDEC Standard EIA/JESD78 IC Latchup Test
- Moisture Sensitivity Level:

$$Pb = 1$$
  
 $Pb-Free = 3$ 

For Additional Information, see Application Note AND8003/D

- Flammability Rating: UL 94 V-0 @ 0.125 in, Oxygen Index: 28 to 34
- Transistor Count = 271 devices
- Pb-Free Packages are Available\*



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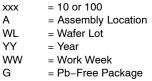
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PLCC-28 FN SUFFIX CASE 776

MARKING DIAGRAM\*



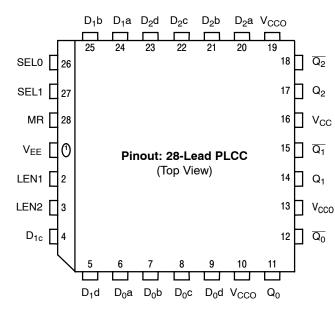


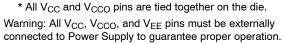
\*For additional marking information, refer to Application Note AND8002/D.

## ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 6 of this data sheet.

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

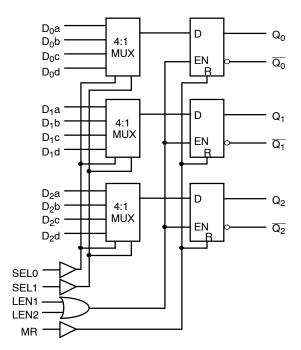




#### Figure 1. 28-Lead Pinout

### Table 1. PIN DESCRIPTION

PIN	FUNCTION
D <sub>0</sub> x – D <sub>3</sub> x	ECL Input Data
SEL0, SEL1	ECL Select Data
LEN1, LEN2	ECL Latch Enables
$Q_0 - Q_2, \overline{Q}_0 - \overline{Q}_2$	ECL Differential Outputs
MR	ECL Master Reset
V <sub>CC</sub> , V <sub>CCO</sub>	Positive Supply
V <sub>EE</sub>	Negative Supply





## Table 2. FUNCTION TABLE

SEL1	SEL0	Data
L	L	а
L	Н	b
Н	L	с
н	Н	d

#### Table 3. MAXIMUM RATINGS

Symbol	Parameter	Condition 1	Condition 2	Rating	Unit
V <sub>CC</sub>	PECL Mode Power Supply	V <sub>EE</sub> = 0 V		8	V
VI	PECL Mode Input Voltage NECL Mode Input Voltage	V <sub>EE</sub> = 0 V V <sub>CC</sub> = 0 V	$\begin{array}{l} V_{I} \leq V_{CC} \\ V_{I} \geq V_{EE} \end{array}$	6 -6	V V
l <sub>out</sub>	Output Current	Continuous Surge		50 100	mA mA
T <sub>A</sub>	Operating Temperature Range			0 to +85	°C
T <sub>stg</sub>	Storage Temperature Range			-65 to +150	°C
$\theta_{JA}$	Thermal Resistance (Junction-to-Ambient)	0 lfpm 500 lfpm	PLCC-28 PLCC-28	63.5 43.5	°C/W °C/W
$\theta_{\text{JC}}$	Thermal Resistance (Junction-to-Case)	Standard Board	PLCC-28	22 to 26	°C/W
T <sub>sol</sub>	Wave Solder Pb Pb-Free			265 265	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

# Table 4. 10E SERIES PECL DC CHARACTERISTICS V<sub>CCx</sub> = 5.0 V, V<sub>EE</sub> = 0.0 V (Note 1)

			0°C			25°C			85°C		
Symbol	Characteristic	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
I <sub>EE</sub>	Power Supply Current		75	90		75	90		75	90	mA
V <sub>OH</sub>	Output HIGH Voltage (Note 2)	3980	4070	4160	4020	4105	4190	4090	4185	4280	mV
V <sub>OL</sub>	Output LOW Voltage (Note 2)	3050	3210	3370	3050	3210	3370	3050	3227	3405	mV
VIH	Input HIGH Voltage	3830	3995	4160	3870	4030	4190	3940	4110	4280	mV
V <sub>IL</sub>	Input LOW Voltage	3050	3285	3520	3050	3285	3520	3050	3302	3555	mV
I <sub>IH</sub>	Input HIGH Current			150			150			150	μA
IIL	Input LOW Current	0.5	0.3		0.5	0.25		0.3	0.2		μA

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

1. Input and output parameters vary 1:1 with V<sub>CC</sub>. V<sub>EE</sub> can vary –0.46 V / +0.06 V. 2. Outputs are terminated through a 50  $\Omega$  resistor to V<sub>CC</sub> – 2.0 V.

Table 5. 10E SERIES NECL DC CHARACTERISTICS V<sub>CCx</sub> = 0.0 V; V<sub>EE</sub> = -5.0 V (Note 3)

			0°C			25°C			85°C		
Symbol	Characteristic	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
I <sub>EE</sub>	Power Supply Current		75	90		75	90		75	90	mA
V <sub>OH</sub>	Output HIGH Voltage (Note 4)	-1020	-930	-840	-980	-895	-810	-910	-815	-720	mV
V <sub>OL</sub>	Output LOW Voltage (Note 4)	-1950	-1790	-1630	-1950	-1790	-1630	-1950	-1773	-1595	mV
V <sub>IH</sub>	Input HIGH Voltage	-1170	-1005	-840	-1130	-970	-810	-1060	-890	-720	mV
V <sub>IL</sub>	Input LOW Voltage	-1950	-1715	-1480	-1950	-1715	-1480	-1950	-1698	-1445	mV
I <sub>IH</sub>	Input HIGH Current			150			150			150	μΑ
IIL	Input LOW Current	0.5	0.3		0.5	0.065		0.3	0.2		μA

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

3. Input and output parameters vary 1:1 with V<sub>CC</sub>. V<sub>EE</sub> can vary –0.46 V / +0.06 V.

4. Outputs are terminated through a 50  $\Omega$  resistor to V<sub>CC</sub> – 2.0 V.

# Table 6. 100E SERIES PECL DC CHARACTERISTICS V<sub>CCx</sub> = 5.0 V; V<sub>EE</sub> = 0.0 V (Note 5)

			0°C			25°C			85°C		
Symbol	Characteristic	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
I <sub>EE</sub>	Power Supply Current		75	90		75	90		86	103	mA
V <sub>OH</sub>	Output HIGH Voltage (Note 6)	3975	4050	4120	3975	4050	4120	3975	4050	4120	mV
V <sub>OL</sub>	Output LOW Voltage (Note 6)	3190	3295	3380	3190	3255	3380	3190	3260	3380	mV
V <sub>IH</sub>	Input HIGH Voltage	3835	3975	4120	3835	3975	4120	3835	3975	4120	mV
V <sub>IL</sub>	Input LOW Voltage	3190	3355	3525	3190	3355	3525	3190	3355	3525	mV
I <sub>IH</sub>	Input HIGH Current			150			150			150	μA
Ι <sub>ΙL</sub>	Input LOW Current	0.5	0.3		0.5	0.25		0.5	0.2		μA

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

5. Input and output parameters vary 1:1 with V<sub>CC</sub>. V<sub>EE</sub> can vary –0.46 V / +0.8 V.

6. Outputs are terminated through a 50  $\Omega$  resistor to V<sub>CC</sub> – 2.0 V.

### Table 7. 100E SERIES NECL DC CHARACTERISTICS V<sub>CCx</sub> = 0 V; V<sub>EE</sub> = -5.0 V (Note 7)

			0°C			25°C			85°C		
Symbol	Characteristic	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
I <sub>EE</sub>	Power Supply Current		75	90		75	90		86	103	mA
V <sub>OH</sub>	Output HIGH Voltage (Note 8)	-1025	-950	-880	-1025	-950	-880	-1025	-950	-880	mV
V <sub>OL</sub>	Output LOW Voltage (Note 8)	-1810	-1705	-1620	-1810	-1745	-1620	-1810	-1740	-1620	mV
V <sub>IH</sub>	Input HIGH Voltage	-1165	-1025	-880	-1165	-1025	-880	-1165	-1025	-880	mV
V <sub>IL</sub>	Input LOW Voltage	-1810	-1645	-1475	-1810	-1645	-1475	-1810	-1645	-1475	mV
I <sub>IH</sub>	Input HIGH Current			150			150			150	μA
IIL	Input LOW Current	0.5	0.3		0.5	0.25		0.5	0.2		μA

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

7. Input and output parameters vary 1:1 with V<sub>CC</sub>. V<sub>EE</sub> can vary –0.46 V / +0.8 V. 8. Outputs are terminated through a 50  $\Omega$  resistor to V<sub>CC</sub> – 2.0 V.

				0°C			25°C			85°C		
Symbol	Characteristic		Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
f <sub>MAX</sub>	Maximum Toggle Frequency		700	1100		700	1100		700	1100		MHz
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation Delay to Output	D SEL0 SEL1 LEN MR	400 550 450 350 350	600 775 650 500 600	900 1050 900 800 825	400 550 450 350 350	600 775 650 500 600	900 1050 900 800 825	400 550 450 350 350	600 775 650 500 600	900 1050 900 800 825	ps
t <sub>s</sub>	Setup Time	D SEL0 SEL1	400 700 600	275 300 400		400 700 600	275 300 400		400 700 600	275 300 400		ps
t <sub>h</sub>	Hold Time	D SEL0 SEL1	300 100 200	-275 -300 -400		300 100 200	-275 -300 -400		300 100 200	-275 -300 -400		ps
t <sub>RR</sub>	Reset Recovery Time		800	600		800	600		800	600		ps
t <sub>PW</sub>	Minimum Pulse Width	MR	400			400			400			ps
t <sub>SKEW</sub>	Within-Device Skew (Note 10)			50			50			50		ps
t <sub>JITTER</sub>	Random Clock Jitter (RMS)			< 1			< 1			< 1		ps
t <sub>r</sub> t <sub>f</sub>	Rise/Fall Time (20 - 80%)		275	475	700	275	475	700	275	475	700	ps

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

9. 10 Series: V<sub>EE</sub> can vary -0.46 V / +0.06 V. 100 Series: V<sub>EE</sub> can vary -0.46 V / +0.8 V.

10. Within-device skew is defined as identical transitions on similar paths through a device.

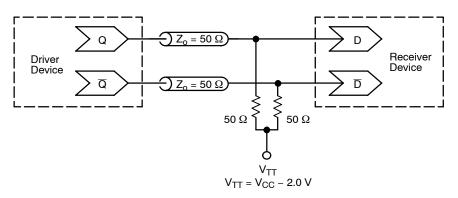


Figure 3. Typical Termination for Output Driver and Device Evaluation (See Application Note AND8020/D - Termination of ECL Logic Devices.)

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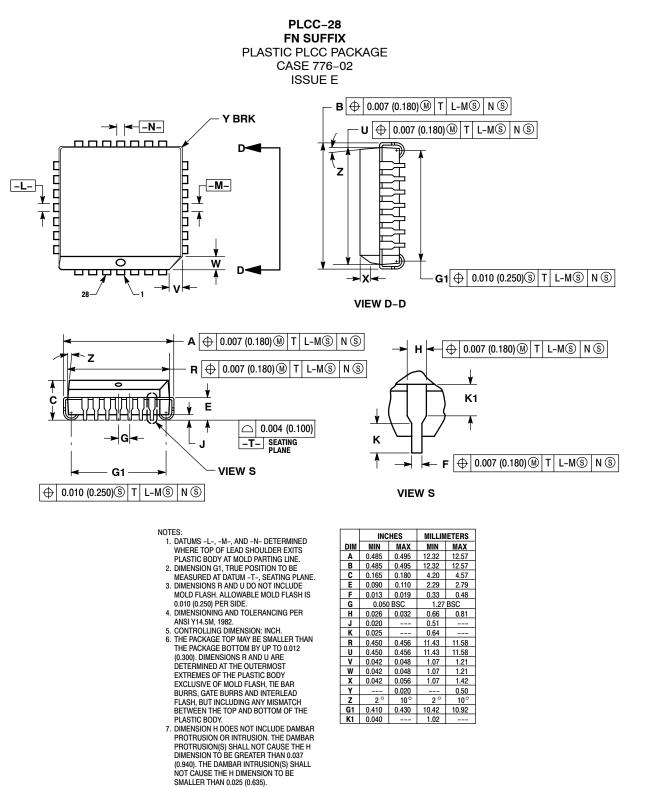
Device	Package	Shipping <sup>†</sup>
MC10E156FN	PLCC-28	37 Units / Rail
MC10E156FNG	PLCC-28 (Pb-Free)	37 Units / Rail
MC10E156FNR2	PLCC-28	500 / Tape & Reel
MC10E156FNR2G	PLCC-28 (Pb-Free)	500 / Tape & Reel
MC100E156FN	PLCC-28	37 Units / Rail

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

### **Resource Reference of Application Notes**

AN1405/D	_	ECL Clock Distribution Techniques
AN1406/D	_	Designing with PECL (ECL at +5.0 V)
AN1503/D	-	ECLinPS <sup>™</sup> I/O SPiCE Modeling Kit
AN1504/D	_	Metastability and the ECLinPS Family
AN1568/D	_	Interfacing Between LVDS and ECL
AN1672/D	_	The ECL Translator Guide
AND8001/D	_	Odd Number Counters Design
AND8002/D	-	Marking and Date Codes
AND8020/D	-	Termination of ECL Logic Devices
AND8066/D	-	Interfacing with ECLinPS
AND8090/D	_	AC Characteristics of ECL Devices

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